Springer Handbookof Materials Data

Warlimont Martienssen Editors

2nd Edition



Springer Handbook of Materials Data

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Springer of Materials Data

Hans Warlimont, Werner Martienssen (Eds.)

2nd Edition With 1110 Figures and 1007 Tables



Editors

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Preface to the First Edition

The Springer Handbook of Condensed Matter and Materials Data is the realization of a new concept in reference literature, which combines introductory and explanatory texts with a compilation of selected data and functional relationships from the fields of solid-state physics and materials in a single volume. The data have been extracted from various specialized and more comprehensive data sources, in particular the Landolt–Börnstein data collection, as well as more recent publications. This Handbook is designed to be used as a desktop reference book for fast and easy finding of essential information and reliable key data. References to more extensive data sources are provided in each section. The main users of this new Handbook are envisaged to be students, scientists, engineers, and other knowledge-seeking persons interested and engaged in the fields of solid-state sciences and materials technologies.

The editors have striven to find authors for the individual sections who were experienced in the full breadth of their subject field and ready to provide succinct accounts in the form of both descriptive text and representative data. It goes without saying that the sections represent the individual approaches of the authors to their subject and their understanding of this task. Accordingly, the sections vary somewhat in character. While some editorial influence was exercised, the flexibility that we have shown is deliberate. The editors are grateful to all of the authors for their readiness to provide a contribution, and to cooperate in delivering their manuscripts and by accepting essentially all alterations which the editors requested to achieve a reasonably coherent presentation.

An onerous task such as this could not have been completed without encouragement and support from the publisher. Springer has entrusted us with this novel project, and Dr. Hubertus von Riedesel has been a persistent but patient reminder and promoter of our work throughout. Dr. Rainer Poerschke has accompanied and helped the editors constantly with his professional attitude and very personable style during the process of developing the concept, soliciting authors, and dealing with technical matters. In the later stages, Dr. Werner Skolaut became a relentless and hard-working member of our team with his painstaking contribution to technically editing the authors' manuscripts and linking the editors' work with the copy editing and production of the book.

We should also like to thank our families for having graciously tolerated the many hours we have spent in working on this publication.

We hope that the users of this Handbook, whose needs we have tried to anticipate, will find it helpful and informative. In view of the novelty of the approach and any possible inadvertent deficiencies which this first edition may contain, we shall be grateful for any criticisms and suggestions which could help to improve subsequent editions so that they will serve the expectations of the users even better and more completely.

September 2004 Frankfurt am Main, Dresden Werner Martienssen, Hans Warlimont

About the Editors

Hans Warlimont studied Physical Metallurgy at the School of Mines in Clausthal, Germany, and received his Dr. rer. nat. Degree from the University of Stuttgart. From 1959 to 1962, he worked in the Fundamental Research Laboratory of U.S. Steel Cooperation, Monroeville, USA. From 1962 to 1974, he headed a research group at the Max-Planck-Institute for Metals Research in Stuttgart, Germany. From 1974 to 1977, he worked as Head of the Advanced Materials Division of Swiss Aluminum AG in Switzerland. From 1977 to 1991, he was Head of Research and Development of Vacuumschmelze Hanau, Germany. From 1991 to 1992, he was Authorized Representative for Corporate R & D of Metallgesellschaft Frankfurt/Main. From 1992 to 1998, he was Scientific Director of the Institute of Solid State and Materials Research Dresden and was Professor of Materials Science at the Dresden University of Technology. His main research areas were structural phase transformations and their effects on the physical and mechanical properties of metals.







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List of Abbreviations

0-D	zero-dimensional	cp-Ti	commercially pure titanium
1-D	one-dimensional	CT	computed tomography
ID-LPS	one-dimensional long-period	CVD	chemical vapor deposition
2.D	superstructure		
2-D 2D I DS	two-dimensional lang pariod	D	
2D-LP5	two-unnensional long-period	DAD	1 11 1 1 4 1 4
2 D	three dimensional	DAP	diallyiphthalate
3-D	four dimensional	DAS	dimer-adatom-stacking fault
4-D 5 D	four-dimensional	DB	dangling bond
3-D		DBR	distributed Bragg reflector
0-D	six-dimensional	DBTT	ductile–brittle transition temperature
		DDT	dichloro diphenyl trichloroethane
A		DFB	distributed feedback
		DFG	difference frequency generation
ABS	poly(acrylonitrile-co-butadiene-co-	DFT	density functional theory
	styrene)	DLAP	deuterated L-arginine phosphate
AFM	atomic force microscopy	DMC	dough molding compound
ARUPS	angle-resolved ultraviolet photoemission	DOP	dioctyl phthalate
	spectroscopy	DOS	density of states
ASA	poly(acrylonitrile-co-styrene-co-	DP	depth profiling
	acrylester)	DSC	differential scanning calorimetry
ASW	acoustic surface wave	DTA	differential thermal analysis
A-TEM	analytical transmission electron		
	microscopy	E	
a.u.	atomic unit		
		EAA	poly(ethylene-co-acrylic acid)
В		EB	electron-beam melting
		EC	ethyl cellulose
BBO	beta barium borate	ECB	edge colony boundary
bcc	body-centered cubic	ECS	electron capture spectroscopy
BCS	Bardeen–Cooper–Schrieffer	ECTFE	poly(ethylene-co-
BET	Brunauer-Emmett-Teller		chlorotrifluoroethylene)
BGB	basal grain boundary	EDTA	ethylenediaminetetraacetic acid
BMC	bulk molding compound	EDX	energy-dispersive X-ray microanalysis
BP	band pass	EELS	electron-energy loss spectroscopy
		EFP	explosively formed penetrator
C		EGB	edge crystal grain boundary
		EIM	polyethylene ionomer
CA	cellulose acetate	ELC	extra low carbon
CAB	cellulose acetobutyrate	EP	epoxide, epoxy
CAS	chemically active species	EPDM	ethylene/propylene/diene-rubber
CBN	cubic boron nitride	ERD	elastic recoil detection
CBO	cesium borate	ESA	electrokinetic sonic amplitude
CCT	continuous-cooling-transformation	ESCA	electron spectroscopy for chemical
CE	carbon equivalent		analysis
CG	compacted graphite	ETFE	poly(ethylene-co-tetrafluoroethylene)
CGO	conventional grain-oriented	EVA	poly(ethylene-co-vinylacetate)
CIGS	copper indium gallium diselenide	EXAFS	extended x-ray absorption fine structure
CLBO	cesium lithium borate		- 1
CMOS	complementary	F	
	metal-oxide-semiconductor		
COC	cvcloolefine copolymer	fcc	face-centered cubic
СР	cellulose propionate	FEP	poly(tetrafluoroethylene-co-
CP	cross polarization		hexafluoropropylene)
	Poluineuron		

FE-SEM FF FG FL FOM G	field-emission scanning electron microscopy flux flow flake graphite fully lamellar figure of merit	IR-DRIFT iso ISS IT ITO i-XPS	infrared spectroscopy diffuse reflection isotactic ion scattering spectroscopy isothermal transformation indium tin oxide imaging x-ray photoelectron spectroscopy
GAR	grain aspect ratio		
GD-MS	glow discharge mass spectrometry	JDOS	joint density of state
GMC	granulated molding compound		
GMR	giant magnetoresistance	К	
GO	grain-oriented		
GP	Guinier–Preston	KE	kinetic energy
GSD	grain size distribution	KRIPES	K-resolved inverse photoelectron spectroscopy
Н		L	
HATOF	helium atom time-of-flight spectroscopy		
HB	Brinell hardness number	LA	longitudinal acoustic
HCN	hydrocyanic acid	LB	Langmuir–Blodgett
пер НОРЕ	high density polyethylene		liquid crystal
HEIS	high-energy ion scattering/high-energy	LCD	liquid crystal display
	ion scattering spectroscopy	LCM	LC materials
HGO	high permeability grain-oriented	LCP	liquid crystal polymer
hh	heavy hole	LDA	local-density approximation
HI	high impact (modifier)	LDPE	low density polyethylene
	Knoop nardness	LEED	low-energy electron diffraction
HMO	heavy-metal oxide	LEIS	ion scattering spectroscopy
HOPG	highly oriented pyrolytic graphite	lh	light hole
HP	high pressure	LHPC	low-heat Portland cement
HPDC	high-pressure die casting	LLDPE	linear low density polyethylene
HPO	hydroxylamine phosphate oxime process	LP	long pass filter
HRA	Rockwell hardness A scale	LPE	liquid phase epitaxy
HKIEM	mign-resolution transmission electron microscopy	LS	laser scattering
HSLA	high-strength low-alloy	Μ	
HT	high temperature		
HV	Vickers hardness	MAS	magic-angle spinning
11 V	viekers hardness	MBE	molecular-beam epitaxy
1		ME	medium-energy ion
		WIEIG	scattering/medium-energy ion scattering
IACS	International Annealed Copper Standard		spectroscopy
IBA	ion bombardment and annealing	MF	melamine formaldehyde
IBAD	ion-beam-assisted deposition	MF	multifilamentary
IC	ion chromatography	MFL	modified fully lamellar
ICP ICP MS	inductively coupled plasma	MITM	magnetic force microscopy methyleyclopentadienyl manganese
101-1010	spectroscopy-mass spectrometry	141141 1	tricarbonyl
ICP-OES	inductively coupled plasma	MNL	modified nearly lamellar
	spectroscopy-optical emission spectral	MOCVD	metal organic chemical vapor deposition
	analysis	MP	multiphase
IINS	inelastic incoherent neutron scattering	MPC	modified Portland cement
IPS	in-plane-switching	MQW	multiple quantum well
IK	infrared spectroscopy	MIJ	magnetic tunnel junction

mu MVA-TFT	monomer unit multidomain vertical alignment thin film transistor	P/M PMMA PMP POM	powder metallurgy poly(methyl methacrylate) poly(4-methyl-1-pentene) poly(oxymethylene)
Ν		POM-R	poly(oxymethylene-co-ethylene)
n-D ND	<i>n</i> -dimensional neutron diffraction	PP PPE PPS	poly(only interference of configuration) poly(phenylene ether) poly(phenylene sulfide)
NG	near-gamma	PSD PSD	polystyrene
NL	nearly lamellar	PSD	particle size distribution
NMK	nuclear magnetic resonance	PSU	porysuitone nortially stabilized zincenia
NO	nonoriented	PSZ	partially stabilized zirconia
NOL	nano-oxide layer		polytetrailuoroetnylene
NPC	normal or ordinary Portland cement	PUK DVC D1	polyuremane plasticized polyurinyl oblarida (75/25)
NRA	nuclear reaction analysis	PVC-P1	plastisized polyvinyl chloride (73/25)
NRC	new RheoCast process	PVC-P2	plastisized polyvinyl chloride (60/40)
n.u.	natural unit	PVC-U	unplastisized polyvinyl chloride
0		PVK PZT	piezoelectric material
<u> </u>		0	
OD ODS	optical density oxide-dispersion-strengthened	Ý	
OPO	optical parametric oscillation	QCSE	quantum-confined Stark effect
		QENS	quasielastic neutron scattering
D		QW	quantum well
		QWR	quantum wire
PA	polyamide	D	
PAII	polyamide 11	<u>n</u>	
PA12	polyamide 12	RABITS	rolling assisted bi-axially textured
PA6	polyamide 6	ICIDITO	substrate
PA610	polyamide 610	RAS	reflectance anisotrony spectroscony
PAGO	polyamide 66	RBA	Rutherford backscattering analysis
PAI	poly(amide imide)	RD	rolling direction
PB DDT	polybulene	RE	rare earth
PBI DDT CE	poly(butylene tereprinalate)	RHEED	reflection high-energy electron
PB1-GF	glashber reinforced poly(butylene terephthalate)	MILLD	diffraction
PC	polycarbonate	RHPC	rapid-hardening Portland cement
PCB	printed circuit board	RIE	reactive ion etching
per	partially crystalline	RRR	residual resistivity ratio
PCTFE	polychlorotrifluoroethylene	RT	room temperature
PE	polyethylene	RTP	room temperature and standard pressure
PED	photoelectron diffraction	RW	weighted sound reduction
PEEK	polvether ether ketone		
PEFC	proton-exchange fuel cell	S	
PEI	polv(ether imide)		
PEM	polymer electrolyte membrane	SAN	polv(styrene-co-acrylonitrile)
PES	poly(ether sulfone)	SAW	surface acoustic wave
PET	poly(ethylene terephthalate)	SB	polv(styrene-co-butadiene)
PF	phenol formaldehyde	SBW	semi borosilicate Wertheim
PGM	platinum group metal	SBZ	surface Brillouin zone
PI	polyimide	SCB	small-angle colony boundary
PIB	polvisobutylene	SCL	shaped charge liner
PILC	paper insulated lead-sheathed cable	SCLS	surface core level shift
PIT	powder-in-tube	SCR	selective catalytic reduction
PL	photoluminescence	SDD	silicon drift detector
PLD	pulsed laser deposition	SDR	surface differential reflectivity
PLF	photoluminescence excitation	SE	secondary electron
PLZT	La-modified PZT	SEM	scanning electron microscopy
		JUN	seaming election meroscopy

SERS	surface-enhanced Raman scattering	ТО	transverse optical branch
SFG	sum frequency generation	TOW	time of wetness
SG	spheroidal graphite	TPD	thermally programmed desorption
SH	second harmonic	TPO	thermally programmed oxidation
SHG	second-harmonic generation	TPR	thermally programmed reduction
SI	International System of Units		thermonlastic polyurathana elastomer
SIMS	secondary-ion mass spectrometry	TrEE	trifluoroethylene
SNMS	secondary neutral mass spectrometry		time temperature transformation
SNR	signal-to-noise ratio	111	time-temperature-transformation
SPARPES	spin-polarized angle-resolved		
STAR ES	nhotoemission spectroscopy	U	
SDI FED	spin-polarized low-energy electron		
SI LEED	diffraction	UF	urea formaldehyde
SOLID	unnaction	UHMWPE	ultrahigh molecular weight polyethylene
SQUID	superconducting quantum interference	ULE	ultralow expansion
CDI	device	UNS	unified numbering system for metals and
SKI	sound reduction index		alloys
SRPC	sulfate-resisting Portland cement	UP	unsaturated polyester
SSMP	semi-solid metal processing	UTS	ultimate tensile strength
SS-XPS	small-spot x-ray photoelectron	UV	ultraviolet radiation
	spectroscopy		
STA	simultaneous thermal analysis	V	
STC	sound transmission classification	-	
STEM	scanning transmission electron	VAC	vacuum-arc casting
	microscopy	VCSEI	vertical cavity surface emitting laser
STM	scanning tunneling microscopy	VCSEL	vinulidana fluorida
STN	supertwisted nematic	VDF	
STP	standard temperature and pressure	VEC	valence electron concentration
svn	syndiotactic	VF	vuicanized liber
Syn	synarouede	VFI	Vogel, Fulcher, and Tammann
		VIP	viewing independent panel
Т		VLS	vapor-liquid-solid
Τ۸	transvarsa accustia	W	
	thermally activated flux flow		
	thellium ersenie selenide	WDX	wavelength-dispersive analysis of X-ray
TAS			······g·····g·····g·····g·····g·····g····
TCD	temperature coefficient	V	
ICK	temperature coefficient of resistivity	Λ	
TE	transverse-electric	VAEC	
TEC	thermal expansion coefficient	XAFS	x-ray absorption spectroscopy
TEM	transmission electron microscopy	XANES	x-ray absorption near-edge structure
TFT	thin-film transistor	XPS	x-ray photoelectron spectroscopy
TG	thermogravimetry	XRD	x-ray diffraction
THF	tetrahydrofuran	XRF	x-ray fluorescence
ТМ	transverse-magnetic		
TMR	tunnel magnetoresistance	Y	
TMT	thermomechanical treatment		
TN	twisted nematic	YS	vield stress
			-

Fundant A

Part A Fundamentals

- 1 The Fundamental Constants Werner Martienssen, Frankfurt am Main, Germany
- 2 The International System of Units (SI), Physical Quantities, and Their Dimensions Werner Martienssen, Frankfurt am Main, Germany
- 3 Rudiments of Crystallography Wolf Assmus, Frankfurt am Main, Germany

4 The Elements

Werner Martienssen, Frankfurt am Main, Germany

1. The Fundamental Constants

Werner Martienssen[†]

In the quantitative description of physical phenomena and physical relationships, we find constant parameters which appear to be independent of the scale of the phenomena, independent of the place where the phenomena happen, and independent of the time when the phenomena are observed. These parameters are called fundamental constants. In Sect. 1.1, we give a qualitative description of these basic parameters and explain how recommended values for the numerical values of the fundamental constants are found. In Sect. 1.2, we present tables of the most recently determined recommended numerical values for a large number of those fundamental constants which play a role in solid-state physics and chemistry and in materials science.

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1.2	The CODATA Recommended Values of the Fundamental Constants	5
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1.1 What are the Fundamental Constants and Who Takes Care of Them?

The fundamental constants are constant parameters in the laws of nature. They determine the size and strength of the phenomena in the natural and technological worlds. We conclude from observation that the numerical values of the fundamental constants are independent of space and time; at least, we can say that if there is any dependence of the fundamental constants on space and time, then this dependence must be an extremely weak one. Also, we observe that the numerical values are independent of the scale of the phenomena observed; for example, they seem to be the same in astrophysics and in atomic physics. In addition, the numerical values are quite independent of the environmental conditions. So we have confidence in the idea that the numerical values of the fundamental constants form a set of numbers which are the same everywhere in the world, and which have been the same in the past and will be the same in the future. Whereas the properties of all material objects in nature are more or less subject to continuous change, the fundamental constants seem to represent a constituent of the world which is absolutely permanent.

On the basis of this expected invariance of the fundamental constants in space and time, it appears reasonable to relate the units of measurement for physical quantities to fundamental constants as far as possible. This would guarantee that also the units of measurement become independent of space and time and of environmental conditions. Within the frame work of the International System of Units (Système International d'Unités, abbreviated to SI), the International Committee for Weights and Measures (Comité International des Poids et Mesures, CIPM) has succeeded in relating a large number of units of measurement for physical quantities to the numerical values of selected fundamental constants; however, several units for physical quantities are still represented by prototypes. For example, the unit of length 1 m, is defined as the distance light travels in vacuum during a fixed time; so the unit of length is related to the fundamental constant c, i.e., the speed of light, and the unit of time, 1 s. The unit of mass, 1 kg, however, is still represented by a prototype, the mass of a metal cylinder made of a platinum-iridium alloy, which is carefully stored at the International Office

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for Weights and Measures (Bureau International des Poids et Mesures, BIPM), at Sèvres near Paris. In a few years, however, it might become possible also to relate the unit of mass to one or more fundamental constants.

The fundamental constants play an important role in basic physics as well as in applied physics and technology; in fact, they have a key function in the development of a system of reproducible and unchanging units for physical quantities. Nevertheless, there is, at present, no theory which would allow us to calculate the numerical values of the fundamental constants. Therefore, National Institutes for Metrology (NIM), together with research institutes and university laboratories, are making efforts worldwide to determine the fundamental constants experimentally with the greatest possible accuracy and reliability. This, of course, is a continuous process, with hundreds of new publications every year.

The Committee on Data for Science and Technology (CODATA), established in 1966 as an interdisciplinary, international committee of the International Council of the Scientific Unions (ICSU), has taken the responsibility for improving the quality, reliability, processing, management, and accessibility of data of importance to science and technology. The CODATA task group on fundamental constants, established in 1969, has taken on the job of periodically providing the scientific and technological community with a selfconsistent set of internationally recommended values of the fundamental constants based on all relevant data available at given points in time. What is the meaning of *recommended values* of the fundamental constants?

Many fundamental constants are not independent of one another; they are related to one another by equations which allow one to calculate a numerical value for one particular constant from the numerical values of other constants. In consequence, the numerical value of a constant can be determined either by measuring it directly or by calculating it from the measured values of other constants related to it. In addition, there are usually several different experimental methods for measuring the value of any particular fundamental constant. This allows one to compute an adjustment on the basis of a least-squares fit to the whole set of experimental data in order to determine a set of best-fitting fundamental constants from the large set of all experimental data. Such an adjustment is done today about every four years by the CODATA task group mentioned above. The resulting set of best-fit values is then called the CODATA recommended values of the fundamental constants based on the adjustment of the appropriate year.

The Tables in Sect. 1.2 show the CODATA recommended values of the fundamental constants of science and technology based on the 2014 adjustment. This adjustment takes into account all data that became available before 31 December 2014. A detailed description of the adjustment has been published by *Mohr* et al. of the National Institute of Standards and Technology, Gaithersburg, in [1.1, 2].

1.2 The CODATA Recommended Values of the Fundamental Constants

1.2.1 The Most Frequently Used Fundamental Constants

Tables 1.1–1.9 list the CODATA recommended values of the fundamental constants based on the 2014 adjustment.

Quantity	Symbol and relation	Numerical value	Units	Relative standard	
				uncertainty	
Speed of light in vacuum	С	299 792 458	m/s	Exact	
Magnetic constant	$\mu_0 = 4\pi \times 10^{-7}$	$12.566370614 \times 10^{-7}$	N/A^2	Exact	
Electric constant	$\varepsilon_0 = 1/(\mu_0 c^2)$	$8.854187817 \times 10^{-12}$	F/m	Exact	
Newtonian constant of gravitation	G	$6.67408(31) \times 10^{-11}$	$m^3/(kg s^2)$	4.7×10^{-5}	
Planck constant	h	$6.626070040(81) \times 10^{-15}$	Js	1.2×10^{-8}	
Reduced Planck constant	$\hbar = h/(2\pi)$	$1.054571800(13) \times 10^{-16}$	Js	1.2×10^{-8}	
Elementary charge	е	$1.6021766208(98) \times 10^{-19}$	С	6.1×10^{-9}	
Fine-structure constant	$\alpha = (1/(4\pi\varepsilon_0))(e^2/(\hbar c))$	$7.2973525664(17) \times 10^{-3}$		2.3×10^{-10}	
Magnetic flux quantum	$\Phi_0 = h/(2e)$	$2.067833831(13) \times 10^{-15}$	Wb	6.1×10^{-9}	
Conductance quantum	$G_0 = 2e^2/h$	$7.7480917310(18) \times 10^{-5}$	S	2.3×10^{-10}	
Rydberg constant	$R_{\infty} = \alpha^2 m_{\rm e} c / (2h)$	10973731.568508(65)	1/m	6.6×10^{-12}	
Electron mass	me	$9.10938356(11) \times 10^{-31}$	kg	1.2×10^{-8}	
Proton mass	mp	$1.672621898(21) \times 10^{-27}$	kg	1.2×10^{-8}	
Proton-electron mass ratio	$m_{\rm p}/m_{\rm e}$	1836.15267389(17)		9.5×10^{-11}	
Avogadro number	$N_{\rm A}, L$	$6.022140857(74) \times 10^{23}$	1/mol	1.2×10^{-8}	
Faraday constant	$F = N_{\rm A} e$	96485.33289(59)	C/mol	6.2×10^{-9}	
Molar gas constant	R	8.3144598(48)	J/(mol K)	5.7×10^{-7}	
Boltzmann constant	$k = R/N_{\rm A}$	$1.38064852(79) \times 10^{-23}$	J/K	1.8×10^{-6}	
Stefan-Boltzmann constant	$\sigma = (\pi^2/60)[k^4/(\hbar^3 c^2)]$	$5.670367(13) \times 10^{-8}$	$W/(m^2 K^4)$	2.3×10^{-6}	

Table 1.1 Brief list of the most frequently used fundamental constants

1.2.2 Detailed Lists of the Fundamental Constants in Different Fields of Application

Table 1.2 Universal constants

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Speed of light in vacuum	С	299 792 458	m/s	Exact
Magnetic constant	$\mu_0 = 4\pi \times 10^{-7}$	$12.566370614 \times 10^{-7}$	N/A^2	Exact
Electric constant	$\varepsilon_0 = 1/(\mu_0 c^2)$	$8.854187817\ldots \times 10^{-12}$	F/m	Exact
Characteristic impedance of vacuum	$Z_0 = (\mu_0 / \varepsilon_0)^{1/2} = \mu_0 c$	376.730313461	Ω	Exact
Newtonian constant of gravitation	G	$6.67408(31) \times 10^{-11}$	$m^3/(kg s^2)$	4.7×10^{-5}
Reduced Planck constant	$\hbar = h/(2\pi)$	$1.054571800(13) \times 10^{-34}$	J s	1.2×10^{-8}
Planck constant	h	$6.626070040(81) \times 10^{-34}$	Js	1.2×10^{-8}
(Ratio)	$G/(\hbar c)$	$6.70861(31) \times 10^{-39}$	$(\text{GeV}/c^2)^2$	4.7×10^{-5}
(Product)	$\hbar c$	197.3269788(12)	MeV fm	6.1×10^{-9}
(Product)	$c_1 = 2\pi h c^2$	$3.741771790(46) \times 10^{-16}$	$W m^2$	1.2×10^{-8}
(Product)	$(1/\pi)c_1 = 2hc^2$	$1.191042953(15) \times 10^{-16}$	W m ² /sr	1.2×10^{-8}
(Product)	$c_2 = h(c/k)$	$1.43877736(83) \times 10^{-2}$	m K	5.7×10^{-7}
Stefan–Boltzmann constant	$\sigma = (\pi^2/60)[k^4/(\hbar^3 c^2)]$	$5.670367(13) \times 10^{-8}$	$W/(m^2 K^4)$	2.3×10^{-6}
Wien displacement law constant	$b = \lambda_{\max} T = c_2 / 4.965114231$	$2.8977729(17) \times 10^{-3}$	m K	5.7×10^{-7}
Planck mass	$m_{\rm P} = (\hbar c/G)^{1/2}$	$2.176470(51) \times 10^{-8}$	kg	2.3×10^{-5}
Planck temperature	$T_{\rm P} = (1/k)(\hbar c^5/G)^{1/2}$	$1.416808(33) \times 10^{32}$	К	2.3×10^{-5}
Planck length	$l_{\rm P} = \hbar/(m_{\rm P}c) = (\hbar G/c^3)^{1/2}$	$1.616229(38) \times 10^{-35}$	m	2.3×10^{-5}
Planck time	$t_{\rm P} = l_{\rm P}/c = (\hbar G/c^5)^{1/2}$	$5.39116(13) \times 10^{-44}$	S	2.3×10^{-5}

Table 1.3 Electromagnetic constants

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Elementary charge	е	$1.6021766208(98) \times 10^{-19}$	С	6.1×10^{-9}
(Ratio)	e/h	$2.417989262(15) \times 10^{14}$	A/J	6.1×10^{-9}
Fine-structure constant	$\alpha = (1/(4\pi\varepsilon_0))(e^2/(\hbar c))$	$7.2973525664(17) \times 10^{-3}$		2.3×10^{-10}
Inverse fine-structure constant	1/α	137.035999139(31)		2.3×10^{-10}
Magnetic flux quantum	$\Phi_0 = h/(2e)$	$2.067833831(13) \times 10^{-15}$	Wb	6.1×10^{-9}
Conductance quantum	$G_0 = 2e^2/h$	$7.7480917310(18) \times 10^{-5}$	S	2.3×10^{-10}
Inverse of conductance quantum	$1/G_0$	12906.4037278(29)	Ω	2.3×10^{-10}
Josephson constant ^a	$K_{\rm J} = 2e/h$	$483597.8525(30) \times 10^9$	Hz/V	6.1×10^{-9}
Von Klitzing constant ^b	$R_{\rm K} = h/e^2 = \mu_0 c/(2\alpha)$	25812.8074555(59)	Ω	2.3×10^{-10}
Bohr magneton	$\mu_{\rm B} = e\hbar/(2m_{\rm e})$	927.4009994(57) $\times 10^{-26}$ 5.7883818012(26) $\times 10^{-5}$	J/T eV/T	6.2×10^{-9} 4.5×10^{-10}
(Ratio)	$\mu_{ m B}/h$	$13.996245042(86) \times 10^9$	Hz/T	6.2×10^{-9}
(Ratio)	$\mu_{\rm B}/(hc)$	46.68644814(29)	1/(mT)	6.2×10^{-9}
(Ratio)	$\mu_{ m B}/k$	0.67171405(39)	K/T	5.7×10^{-7}
Nuclear magneton	$\mu_{\rm N} = e\hbar/(2m_{\rm p})$	$5.050783699(31) \times 10^{-27}$ $3.1524512550(15) \times 10^{-8}$	J/T eV/T	6.2×10^{-9} 4.6×10^{-10}
(Ratio)	$\mu_{ m N}/h$	7.622593285(47)	MHz/T	6.2×10^{-9}
(Ratio)	$\mu_{\rm N}/(hc)$	$2.542623432(16) \times 10^{-2}$	1/(mT)	6.2×10^{-9}
(Ratio)	$\mu_{ m N}/k$	$3.6582690(21) \times 10^{-4}$	K/T	5.7×10^{-7}

^a See Table 2.16 for the conventional value adopted internationally for realizing representations of the volt using the Josephson effect. ^b See Table 2.16 for the conventional value adopted internationally for realizing representations of the ohm using the quantum Hall effect.

Table 1.4 Thermodynamic constants

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Avogadro constant	$N_{\rm A}, L$	$6.022140857(74) \times 10^{23}$	1/mol	1.2×10^{-8}
Atomic mass constant	$m_u = (1/12)m(^{12}\text{C})$ = $(1/N_\text{A}) \times 10^{-3} \text{ kg}$	$1.660539040(20) \times 10^{-27}$	kg	1.2×10^{-8}
Energy equivalent	$m_{\mu}c^2$	$1.492418062(18) \times 10^{-10}$	J	1.2×10^{-8}
of atomic mass constant		931.4940954(57)	MeV	6.2×10^{-9}
Faraday constant	$F = N_{\rm A} e$	96485.33289(59)	C/mol	6.2×10^{-9}
Molar Planck constant	N _A h	$3.9903127110(18) \times 10^{-10}$	J s/mol	4.5×10^{-10}
(Product)	N _A hc	0.119626565582(54)	J m/mol	4.5×10^{-10}
Molar gas constant	R	8.3144598(48)	J/(K mol)	5.7×10^{-7}
Boltzmann constant	$k = R/N_{\rm A}$	$1.38064852(79) \times 10^{-23}$	J/K	5.7×10^{-7}
		$8.6173303(50) \times 10^{-5}$	eV/K	5.7×10^{-7}
(Ratio)	k/h	$2.0836612(12) \times 10^{10}$	Hz/K	5.7×10^{-7}
(Ratio)	k/hc	69.503457(40)	1/(m K)	5.7×10^{-7}
Molar volume of ideal gas	$V_m = RT/p$	$22.710947(13) \times 10^{-3}$	m ₃ /mol	5.7×10^{-7}
at STP	at $T = 273.15 \text{ K}$			
	and $p = 100 \mathrm{kPa}$			
Loschmidt constant	$n_0 = N_{\rm A}/V_{\rm m}$	$2.6516467(15) \times 10^{25}$	$1/m^{3}$	5.7×10^{-7}
Stefan-Boltzmann constant	$\sigma = (\pi^2/60)[k^4/(\hbar^3 c^2)]$	$5.670367(13) \times 10^{-8}$	$W/(m^2 K^4)$	2.3×10^{-6}
Wien displacement law constant	$b = \lambda_{\max} T = c_2 / 4.965114231$	$2.8977729(17) \times 10^{-3}$	mK	5.7×10^{-7}

1.2.3 Constants from Atomic Physics and Particle Physics

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Rydberg constant	$R_{\infty} = \alpha^2 m_{\rm e} c/2h$	10973731.568508(65)	1/m	5.9×10^{-12}
(Product)	$R_{\infty}c$	$3.289841960355(19) \times 10^{15}$	Hz	5.9×10^{-12}
(Product)	$R_{\infty}hc$	$2.179872325(27) \times 10^{-18}$ 13.605693009(84)	J eV	1.2×10^{-8} 6.1×10^{-9}
Bohr radius	$a_0 = \alpha/(4\pi R_\infty)$ = $4\pi\varepsilon_0\hbar^2/(m_e e^2)$	$0.52917721067(12) \times 10^{-10}$	m	2.3×10^{-10}
Hartree energy	$E_{\rm H} = e^2 / (4\pi\varepsilon_0 a_0)$ $= 2R_{\infty}hc = \alpha^2 m_0 c^2$	$4.359744650(54) \times 10^{-18}$ 27.21138602(17)	J eV	1.2×10^{-8} 6.1×10^{-9}
Quantum of circulation	$h/(2m_{\rm e})$	$3.6369475486(17) \times 10^{-4}$	m^2/s	4.5×10^{-10}
(Product)	$h/m_{\rm e}$	$7.2738950972(33) \times 10^{-4}$	m ² /s	4.5×10^{-10}

Table 1.5 Constants from atomic physics

Table 1.6 Properties of the electron

Quantity	Symbol and relation	Numerical value	Units	Relative
				standard
				uncertainty
Electron mass	me	$9.10938356(11) \times 10^{-31}$	kg	1.2×10^{-8}
		$5.48579909070(16) \times 10^{-4}$	u	2.9×10^{-11}
Energy equivalent of electron mass	$m_{\rm e}c^2$	$8.18710565(10) \times 10^{-14}$	J	1.2×10^{-8}
		0.5109989461(31)	MeV	6.2×10^{-9}
Electron-proton mass ratio	$m_{\rm e}/m_{\rm p}$	$5.44617021352(52) \times 10^{-4}$		9.5×10^{-11}
Electron-neutron mass ratio	$m_{\rm e}/m_{\rm n}$	$5.4386734428(27) \times 10^{-4}$		4.9×10^{-10}
Electron-muon mass ratio	$m_{\rm e}/m_{\rm \mu}$	$4.83633170(11) \times 10^{-3}$		2.2×10^{-8}
Electron molar mass	$M(e) = N_A m_e$	$5.48579909070(16) \times 10^{-7}$	kg/mol	2.9×10^{-11}
Charge-to-mass ratio	$-e/m_{\rm e}$	$-1.758820024(11) \times 10^{11}$	C/kg	6.2×10^{-9}
Compton wavelength	$\lambda_{\rm C} = h/(m_{\rm e}c)$	$2.4263102367(11) \times 10^{-12}$	m	4.5×10^{-10}
(Ratio)	$\lambda_{\rm C}/(2\pi) = \alpha a_0 = \alpha^2/(4\pi R_\infty)$	$386.15926764(18) \times 10^{-15}$	m	4.5×10^{-10}
Classical electron radius	$r_{\rm e} = \alpha^2 a_0$	$2.8179403227(19) \times 10^{-15}$	m	6.8×10^{-10}
Thomson cross section	$\sigma_{\rm e} = (8\pi/3)r_{\rm e}^2$	$0.66524587158(91) \times 10^{-28}$	m ²	1.4×10^{-9}
Magnetic moment	μ_{e}	$-928.4764620(57) \times 10^{-26}$	J/T	6.2×10^{-9}
Ratio of magnetic moment	$\mu_{ m e}/\mu_{ m B}$	-1.00115965218091(26)		2.6×10^{-13}
to Bohr magneton				
Ratio of magnetic moment	$\mu_{ m e}/\mu_{ m N}$	-1838.28197234(17)		9.5×10^{-11}
to nuclear magneton				
Ratio of magnetic moment	$\mu_{ m e}/\mu_{ m p}$	-658.2106866(20)		3.0×10^{-9}
to proton magnetic moment				
Ratio of magnetic moment	$\mu_{\rm e}/\mu_{\rm n}$	960.92050(23)		2.4×10^{-7}
to neutron magnetic moment				
Electron magnetic moment anomaly	$a_{\rm e} = \mu_{\rm e} /(\mu_{\rm B} - 1)$	$1.15965218091(26) \times 10^{-3}$		2.3×10^{-10}
g-factor	$g_{\rm e} = -2(1+a_{\rm e})$	-2.00231930436182(52)		2.6×10^{-13}
Gyromagnetic ratio	$\gamma_{\rm e} = 2 \mu_{\rm e} /\hbar$	$1.760859644(11) \times 10^{11}$	1/(sT)	6.2×10^{-9}
(Ratio)	$\gamma_{\rm e}/(2\pi)$	28024.95164(17)	MHz/T	6.2×10^{-9}

Table 1.7	Properties	of the	proton
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Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Proton mass	mp	$1.672621898(21) \times 10^{-27} 1.007276466879(91)$	kg u	1.2×10^{-8} 9.0×10^{-11}
Energy equivalent of proton mass	$m_{\rm p}c^2$	$1.503277593(18) \times 10^{-10}$ 938.2720813(58)	J MeV	1.2×10^{-8} 6.2×10^{-9}
Proton-electron mass ratio	$m_{\rm p}/m_{\rm e}$	1836.15267389(17)		9.5×10^{-11}
Proton-neutron mass ratio	$m_{\rm p}/m_{\rm n}$	0.99862347844(51)		5.1×10^{-10}
Proton molar mass	$M(\mathbf{p}) = N_{\mathrm{A}}m_{\mathrm{p}}$	$1.007276466879(91) \times 10^{-3}$	kg/mol	9.0×10^{-11}
Charge-to-mass ratio	e/mp	$9.578833226(59) \times 10^7$	C/kg	6.2×10^{-9}
Compton wavelength	$\lambda_{\rm C,p} = h/(m_{\rm p}c)$	$1.32140985396(61) \times 10^{-15}$	m	4.6×10^{-10}
(Ratio)	$(1/(2\pi))\lambda_{C,p}$	$0.210308910109(97) \times 10^{-15}$	m	4.6×10^{-10}
rms charge radius	R _p	$0.8751(61) \times 10^{-15}$	m	7.0×10^{-3}
Magnetic moment	$\mu_{\rm p}$	$1.4106067873(97) \times 10^{-26}$	J/T	6.9×10^{-9}
Ratio of magnetic moment to Bohr magneton	$\mu_{\rm p}/\mu_{\rm B}$	$1.5210322053(46) \times 10^{-3}$		3.0×10^{-9}
Ratio of magnetic moment to nuclear magneton	$\mu_{ m p}/\mu_{ m N}$	2.7928473508(85)		3.0×10^{-9}
Ratio of magnetic moment to neutron magnetic moment	$\mu_{\rm p}/\mu_{\rm n}$	-1.45989805(34)		2.4×10^{-7}
g-factor	$g_{\rm p} = 2\mu_{\rm p}/\mu_{\rm N}$	5.585694702(17)		3.0×10^{-9}
Gyromagnetic ratio	$\gamma_{\rm p} = 2\mu_{\rm p}/\hbar$	$2.67522205(23) \times 10^8$	1/(sT)	6.9×10^{-9}
(Ratio)	$(1/(2\pi))\gamma_p$	42.57747892(29)	MHz/T	6.9×10^{-9}

Table 1.8 Properties of the neutron

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Neutron mass	m _n	$\begin{array}{c} 1.674927471(21) \times 10^{-27} \\ 1.00866491588(49) \end{array}$	kg u	1.2×10^{-8} 4.9×10^{-10}
Energy equivalent	$m_{\rm n}c^2$	939.5654133(58)	MeV	6.2×10^{-9}
Neutron-electron mass ratio	$m_{\rm n}/m_{\rm e}$	1838.68366158(90)		4.9×10^{-10}
Neutron-proton mass ratio	$m_{\rm n}/m_{\rm p}$	1.00137841898(51)		5.1×10^{-10}
Molar mass	$M(\mathbf{n}) = N_{\mathrm{A}}m_{\mathrm{n}}$	$1.00866491588(49) \times 10^{-3}$	kg/mol	5.5×10^{-10}
Compton wavelength	$\lambda_{\rm C,n} = h/(m_{\rm n}c)$	$1.31959090481(88) \times 10^{-15}$	m	6.7×10^{-10}
(Ratio)	$(1/(2\pi))\lambda_{C,n}$	$0.21001941536(14) \times 10^{-15}$	m	6.7×10^{-10}
Magnetic moment	$\mu_{ m n}$	$-0.96623650(23) \times 10^{-26}$	J/T	2.4×10^{-7}
Ratio of magnetic moment to Bohr magneton	$\mu_{ m n}/\mu_{ m B}$	$-1.04187563(25) \times 10^{-3}$		2.4×10^{-7}
Ratio of magnetic moment to nuclear magneton	$\mu_{ m n}/\mu_{ m N}$	-1.91304273(45)		2.4×10^{-7}
Ratio of magnetic moment to electron magnetic moment	$\mu_{\rm n}/\mu_{\rm e}$	$1.04066882(25) \times 10^{-3}$		2.4×10^{-7}
Ratio of magnetic moment to proton magnetic moment	$\mu_{\rm n}/\mu_{\rm p}$	-0.68497934(16)		2.4×10^{-7}
g-factor	$g_{\rm n} = 2\mu_{\rm n}/\mu_{\rm N}$	-3.82608545(90)		2.4×10^{-7}
Gyromagnetic ratio	$\gamma_{\rm n} = 2 \mu_{\rm n} /\hbar$	$1.83247172(43) \times 10^8$	1/(sT)	2.4×10^{-7}
(Ratio)	$(1/(2\pi))\gamma_n$	29.1646933(69)	MHz/T	2.4×10^{-7}

Table 1.9 Properties of the alpha particle

Quantity	Symbol and relation	Numerical value	Units	Relative standard uncertainty
Alpha particle mass ^a	m_{α}	$\begin{array}{l} 6.644657230(82) \times 10^{-27} \\ 4.001506179127(63) \end{array}$	kg u	1.2×10^{-8} 1.6×10^{-11}
Energy equivalent of alpha particle mass	$m_{\alpha}c^2$	$5.971920097(73) \times 10^{-10}$ 3727.379378(23)	J MeV	1.2×10^{-8} 6.2×10^{-9}
Ratio of alpha particle mass to electron mass	$m_{\alpha}/m_{\rm e}$	7294.29954136(24)		3.3×10^{-11}
Ratio of alpha particle mass to proton mass	$m_{\alpha}/m_{\rm p}$	3.97259968907(36)		9.2×10^{-11}
Alpha particle molar mass	$M(\alpha) = N_{\rm A} m_{\alpha}$	$4.001506179127(63) \times 10^{-3}$	kg/mol	1.6×10^{-11}

^a The mass of the alpha particle in units of the atomic mass unit u is given by $m_{\alpha} = A_r(\alpha)$ u; in words, the alpha particle mass is given by the relative atomic mass $A_r(\alpha)$ of the alpha particle, multiplied by the atomic mass unit u

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2. The International System of Units (SI), Physical Quantities, and Their Dimensions

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In this chapter, we introduce the International System of Units (SI) on the basis of the SI brochure Le Système International d'unités (SI) [2.1], supplemented by [2.2]. We give a short review of how the SI was worked out and who is responsible for the further development of the system. Following the above-mentioned publications, we explain the concepts of base physical quantities and derived physical quantities on which the SI is founded, and present a detailed description of the SI base units and of a large selection of SI derived units. The base units comprise the meter, the kilogram, the second, the ampere, the kelvin, the mole, and the candela. For derived units, we describe how they are defined by equations in terms of the base physical quantities as products or ratios of the units for the base quantities. We also discuss a number of non-SI units which still are in use, especially in some specialized fields. A table (Table 2.17) presenting the values of various energy equivalents closes the chapter.

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2.1 The International System of Units (SI)

All data in this handbook are given in the International System of Units (Système International d'Unités), abbreviated internationally to SI, which is the modern metric system of measurement and is acknowledged worldwide. The system of SI units was introduced by the General Conference of Weights and Measures (Conférence Générale des Poids et Measures), abbreviated internationally to CGPM, in 1960. The system not only is used in science, but also is dominant in technology, industrial production, and international commerce and trade.

Who takes care of this system of SI units?

The Bureau International des Poids et Mesures (BIPM), which has its headquarters in Sèvres near Paris, has taken on a commitment to ensure worldwide unification of physical measurements. Its function is thus to:

- Establish fundamental standards and scales for the measurement of the principal physical quantities and maintain the international prototypes
- Carry out comparison of national and international standards
- Ensure the coordination of the corresponding measuring techniques
- Carry out and coordinate measurements of the fundamental physical constants relevant to those activities.

The BIPM operates under the exclusive supervision of the Comité International des Poids et Mesures (CIPM), which itself comes under the authority of the Conférence Générale des Poids et Mesures and reports to it on the work accomplished by the BIPM. The BIPM itself was set up by the convention du Mètre signed in Paris in 1875 by 17 states during the final session of the Conference on the Meter. The convention was amended in 1921.

Delegates from all member states of the Convention du Mètre attend the Conférence Générale, which, at present, meets every four years. The function of these meetings is to:

- Discuss and initiate the arrangements required to ensure the propagation and improvement of the International System of Units.
- Confirm the results of new fundamental metrological determinations and confirm various scientific resolutions with international scope.
- Take all major decisions concerning the finance, organization, and development of the BIPM.

The CIPM has 18 members, each from a different state; at present, it meets every year. The officers of this committee present an annual report on the administrative and financial position of the BIPM to the governments of the member states of the Convention du Mètre. The principal task of the CIPM is to ensure worldwide uniformity in units of measurement. It does this by direct action or by submitting proposals to the CGPM.

The BIPM publishes monographs on special metrological subjects and the brochure *Le Système international d'unités (SI)* [2.1,2], which is periodically updated and in which all decisions and recommendations concerning units are collected together.

The scientific work of the BIPM is published in the open scientific literature, and an annual list of publications appears in the *Procès-Verbaux* of the CIPM.

Since 1965, *Metrologica*, an international journal published under the auspices of the CIPM, has printed articles dealing with scientific metrology, improvements in methods of measurements, and work on standards and units, as well as reports concerning the activities, decisions, and recommendations of the various bodies created under the Convention du Mètre.

2.2 Physical Quantities

Physical quantities are tools which allow us to specify and quantify the properties of physical objects and to model the events, phenomena, and patterns of behavior of objects in nature and in technology. The system of physical quantities used with the SI units is dealt by Technical Committee 12 of the International organization for standardization (ISO/TC 12). Since 1955, ISO/TC 12 has published a series of international standards on quantities and their units, in which the use of SI units is strongly recommended.

2.2.1 How Are Physical Quantities Defined?

It turns out that it is possible to divide the system of all known physical quantities into two groups:

- A small number of *base quantities*
- A much larger number of other quantities, which are called *derived quantities*.x

The derived quantities are introduced into physics unambiguously by a defining equation in terms of the base quantities; the relationships between the derived quantities and the base quantities are expressed in a series of equations, which contain a good deal of our knowledge of physics but are used in this system as the defining equations for new physical quantities. One might say that, in this system, physics is described in the rather low-dimensional space of a small number of base quantities. Base quantities, on the other hand, cannot be introduced by a defining equation; they cannot be traced back to other quantities; this is what we mean by calling them *base*. How can base quantities then be introduced unambiguously into physics at all?

Base physical quantities are introduced into physics in three steps:

- We borrow the qualitative meaning of the word for a base quantity from the meaning of the corresponding word in everyday language.
- We specify this meaning by indicating an appropriate method for measuring the quantity. For example, length is measured by a measuring rule, and time is measured by a clock.
- We fix a unit for this quantity, which allows us to communicate the result of a measurement. Length, for example, is measured in meters; time is measured in seconds.

On the basis of these three steps, it is expected that everyone will understand what is meant when the name of a base quantity is mentioned.

In fact, the number of base quantities chosen and the selection of the quantities which are considered as base quantities are a matter of expediency; in different fields and applications of physics, it might well be expedient to use different numbers of base quantities and different selections of base quantities. It should be kept